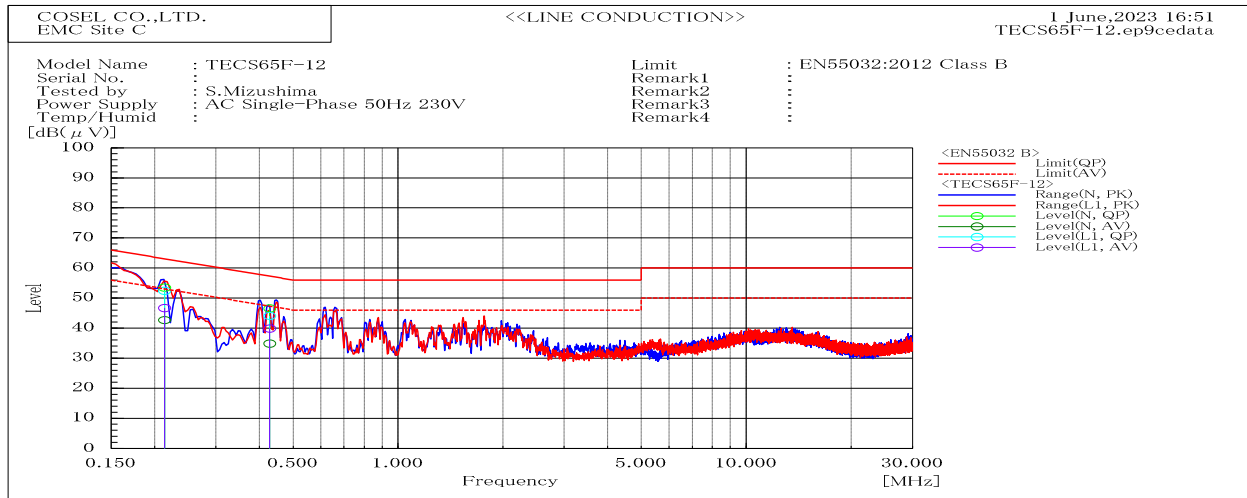
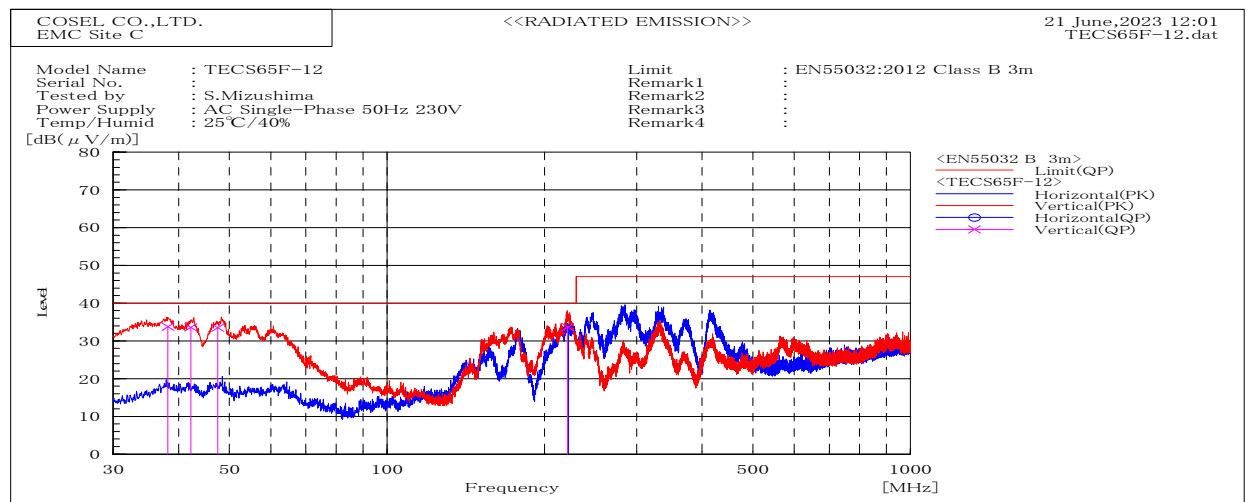


DATA SHEET		Date	12-Oct-23
Model	TECS65F-12	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima



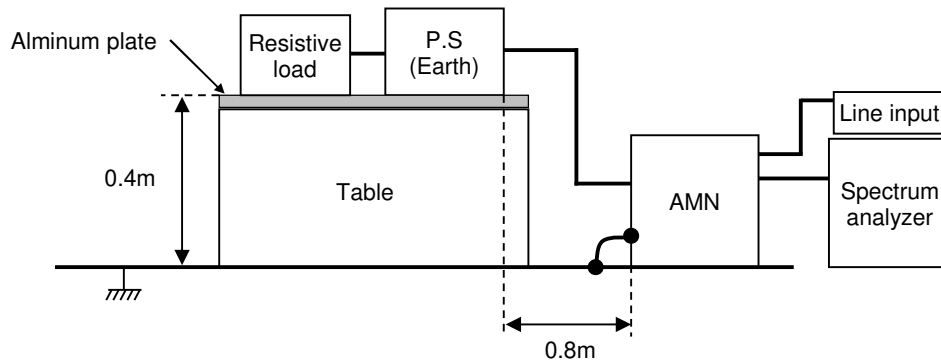
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.214	L1	52.4	46.7	63.1	53.1	10.7	6.4	Pass	
0.429	L1	44.1	39.9	57.3	47.3	13.2	7.4	Pass	
0.214	N	53.5	42.7	63.1	53.1	9.6	10.4	Pass	
0.429	N	46.6	34.8	57.3	47.3	10.7	12.5	Pass	



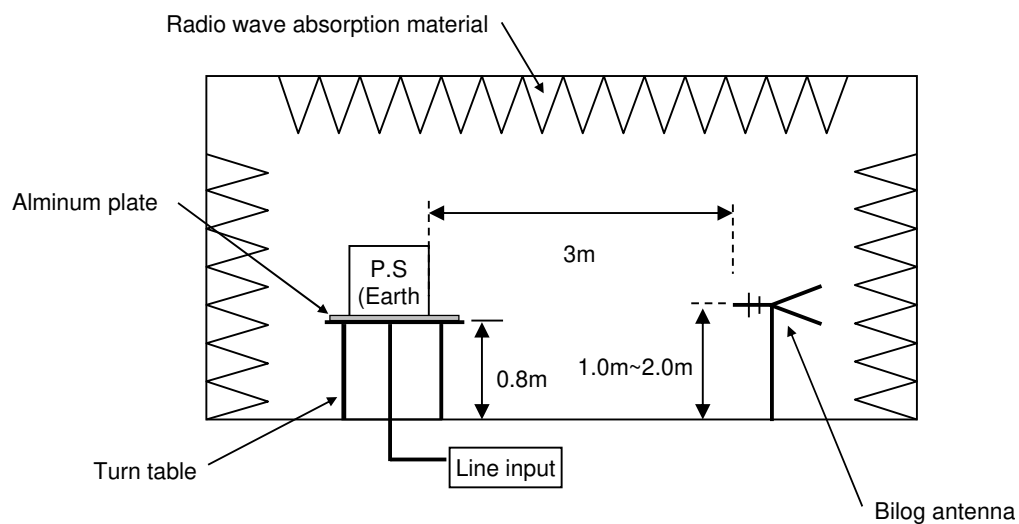
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP				
38.134	V	Stable	33.8	40	6.2	Pass	100	174.6	
42.174	V	Stable	33.6	40	6.4	Pass	100.2	191.8	
47.489	V	Stable	33.5	40	6.5	Pass	100.4	242.7	
221.419	V	Stable	33.7	40	6.3	Pass	100.4	190.4	
222.438	H	Stable	33	40	7	Pass	132.6	65.2	

DATA SHEET		Date	12-Oct-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima

1. Line conduction



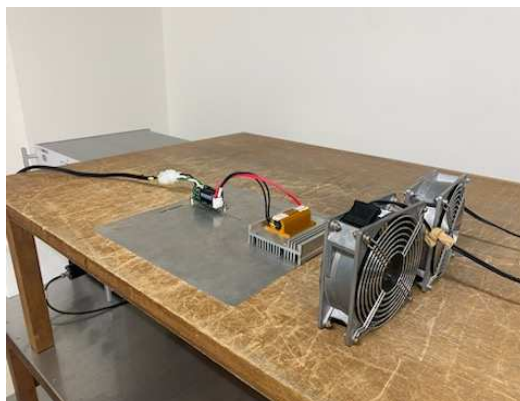
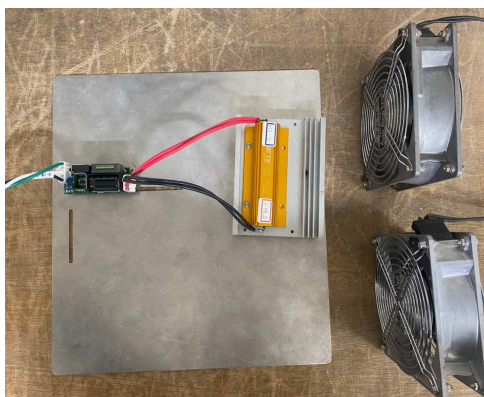
2. Radiated emission



Conditions

Test : EMI
Model Nam: TECS65F-12

1.LINE CONDUCTION



2.RADIATED EMISSION

